

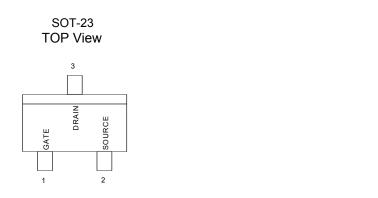
#### **GENERAL DESCRIPTION**

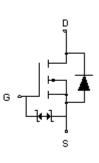
This N-Channel enhancement mode field effect transistor is produced using high cell density, DMOS technology. These products have been designed to minimize on-state resistance while provide rugged, reliable, and fast switching and ESD enhanced performance. It can be used in most applications requiring up to 115mA DC and can deliver pulsed currents up to 800mA. This product is particularly suited for low voltage, low current applications such as small servo motor control, power MOSFET gate drivers, and other switching applications.

#### **FEATURES**

- ♦ High Density Cell Design for Low R<sub>DS(ON)</sub>
- Voltage Controlled Small Signal Switch
- Rugged and Reliable
- High Saturation Current Capability
- ESD Protected 2KV HBM

#### **PIN CONFIGURATION**





**SYMBOL** 

N-Channel MOSFET

# **ORDERING INFORMATION**

Part Number	Package
CMT2N7002K	SOT-23
CMT2N7002KX*	SOT-23

\*Note: X : Suffix for Halogen Free Product

# **ABSOLUTE MAXIMUM RATINGS**

Rating		Value	Unit
Drain Source Voltage		60	V
Drain-Gate Voltage ( $R_{GS}$ = 1.0M $\Omega$ )		60	V
Drain to Current – Continuous		115	mA
- Pulsed	I <sub>DM</sub>	800	
Gate-to-Source Voltage — Continue		±15	V
<ul> <li>Non-repetitive</li> </ul>	V <sub>GSM</sub>	±15	V
Total Power Dissipation	PD	225	mW
Derate above 25℃		1.8	mW/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Thermal Resistance – Junction to Ambient	$\theta_{JA}$	417	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	300	°C



# ELECTRICAL CHARACTERISTICS

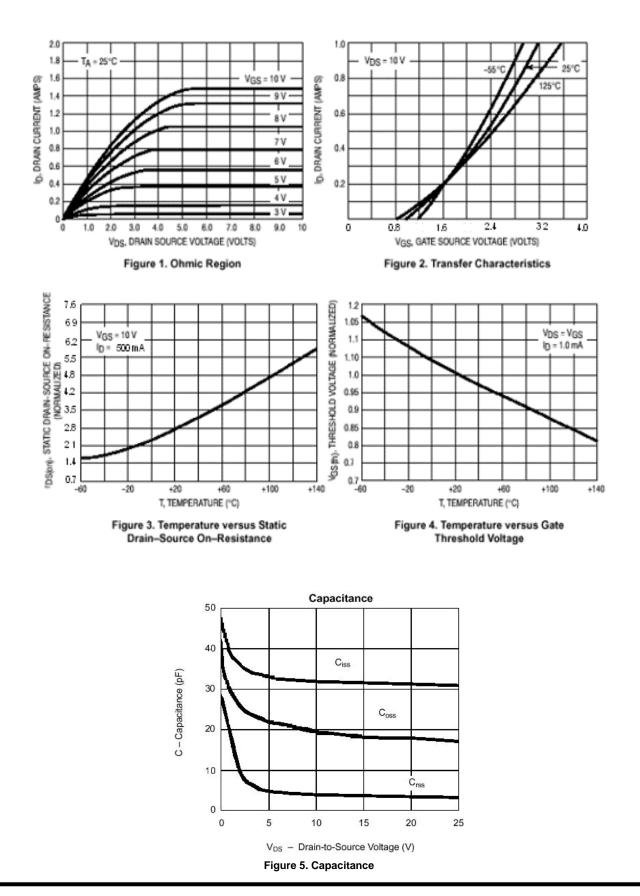
Unless otherwise specified,  $T_J$  = 25  $^\circ\!\mathrm{C}$  .

Characteristic	Symbol	CMT2N7002K				
			Min	Тур	Max	Units
Drain-Source Breakdown Voltage	)	V <sub>(BR)DSS</sub>		60		V
$(V_{GS} = 0 V, I_D = 10 \mu A)$						
Drain-Source Leakage Current		I <sub>DSS</sub>				
$(V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V})$					1.0	$\mu A$
$(V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}C)$					0.5	mA
Gate-Source Leakage Current-Fo	prward ( $V_{gsf}$ = 15 V)	I <sub>GSSF</sub>			1.0	μA
Gate-Source Leakage Current-Reverse (V <sub>gsf</sub> = -15 V)		I <sub>GSSF</sub>			-1.0	μA
Gate Threshold Voltage *		V <sub>GS(th)</sub>		1.0	2.5	V
$(V_{DS} = V_{GS}, I_D = 250 \ \mu A)$						
On-State Drain Current (V_Ds $\geq$ 2.0 V_DS(on), V_Gs = 10V)		I <sub>d(on)</sub>		500		mA
Static Drain-Source On-Resistan	ce *	R <sub>DS(on)</sub>				Ω
(V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5A)					7.5	
(V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5A, T <sub>J</sub> = 125℃)					13.5	
(V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 50mA)					7.5	
$(V_{GS} = 5.0 \text{ V}, I_D = 50 \text{mA}, T_J = 125^{\circ}\text{C})$					13.5	
Drain-Source On-Voltage *		V <sub>DS(on)</sub>				V
(V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5A)					3.75	
(V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 50mA)					0.375	
Forward Transconductance (V_{DS} $\geq$ 2.0 V_{DS(on)}, I_{D} = 200mA) *		<b>g</b> fs		80		mmhos
Input Capacitance	$(1) - 25 \times 1 = 0 \times 1$	C <sub>iss</sub>			50	pF
Output Capacitance	(V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz)	C <sub>oss</sub>			25	pF
Reverse Transfer Capacitance		C <sub>rss</sub>			5.0	pF
Turn-On Delay Time	$(V_{DD} = 25 \text{ V}, I_D = 500 \text{ mA},$	t <sub>d(on)</sub>			20	ns
Turn-Off Delay Time	$V_{gen}$ = 10 V, $R_G$ = 25 $\Omega$ , $R_L$ = 50 $\Omega$ ) *	t <sub>d(off)</sub>			40	ns
Diode Forward On-Voltage (IS = 115 mA, VGS = 0V)		V <sub>SD</sub>			-1.5	V
Source Current Continuous (Body Diode)		I <sub>S</sub>			-115	mA
Source Current Pulsed		I <sub>SM</sub>			-800	mA

\* Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%

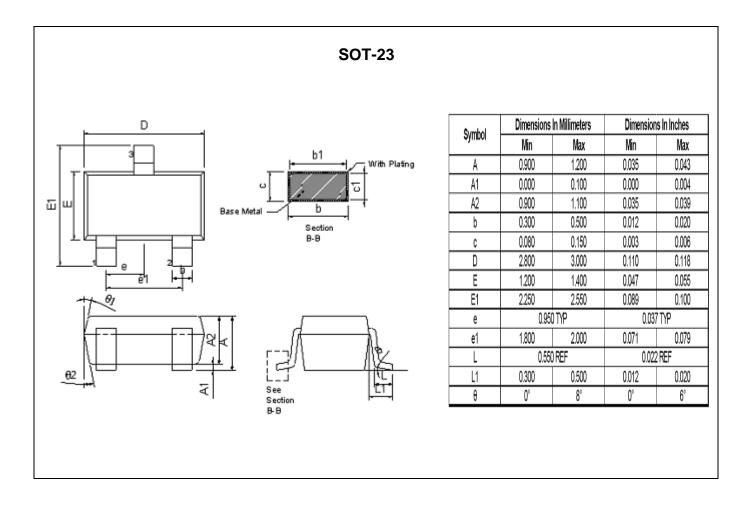








# PACKAGE DIMENSION





# **IMPORTANT NOTICE**

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